Search Notes

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Applicant(s)/Patent under Reexamination

JAPP ET AL.

Art Unit

Thinh T. Nguyen

10/812,890

Examiner

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SEARCHED						
Class	Subclass	Date	Examiner			
257	762	10/27/2005	TTN			
257	760	10/27/2005	TTN			
257	703	10/28/2005	TTN			
257	758	10/28/2005	TTN			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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